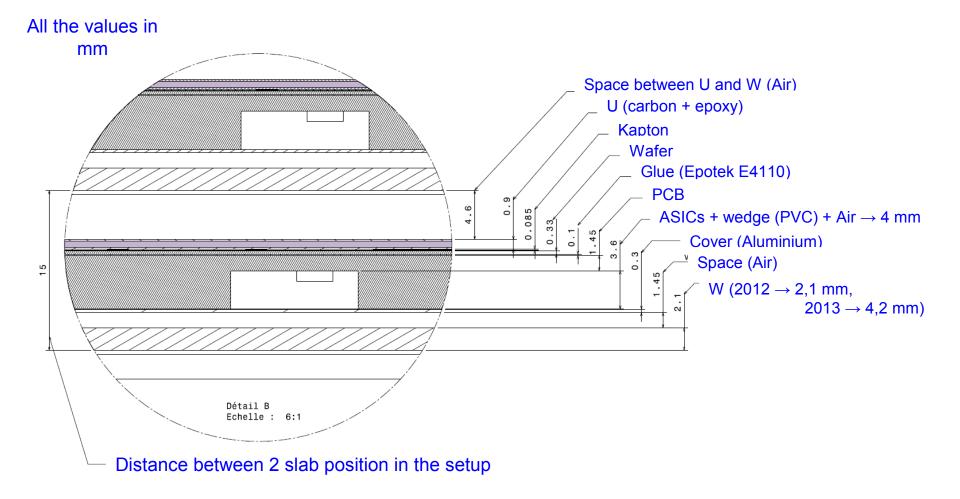
Summary: Technological prototype simulation for DESY Test beam

Geometry

Thanks to Mickael and Rémi

Wafer: size = 88.49 mm Interpixel = 0,05 mm



Technological prototype simulation

Materials

Information from previous CALICE prototypes in Mokka, other experiments, manufacturers...

- \rightarrow better to measure density and composition (if possible)
- <u>W</u> Tungsten d=19.3 g/cm3
- Kapton d=1.42 g/cm3
 - + Carbon; f=0.691133
 - + Hydrogen; f=0.026362
 - + Oxygen; f=0.209235
 - + Nitrogen ; f=0.073270
- <u>U</u> d=1.6 g/cm3
 - + Carbon; f=0.8466
 - + Hydrogen; f=0.0426
 - + Oxygen; f=0.0967
 - + Nitrogen ; f=0.0141

- Epotek4110 d=2.57 g/cm3
 - + Carbon; f=0.431
 - + Hydrogen; f=0.046
 - + Oxygen; f=0.125
 - + Nitrogen ; f=0.014
 - + Silver ; f=0.385
- Epoxy d=1.3 g/cm3
 - + Carbon; n=15
 - + Hydrogen; n=44
 - + Oxygen; n=7

Epotek

 \rightarrow I considered homogeneous layer of Epotek4110 with reduced density to take into account space between glue dots. d=1.5 g/cm3

ASICs (packaging)+ wedge (PVC) + Air

 \rightarrow I considered homogeneous layer of PVC with reduced density to take into account empty regions (ASICs packaging is assimilated to PVC). d=0.9 g/cm3

Wafer - Silicon - d=2.33 g/cm3		
<u>Cover</u> - Aluminium - d=2.7 g/cm3 <u>PCB</u> - d=3. g/cm3 + Copper ; f=0.4276 + g10 ; f=0.5724	<u>G10</u> - d=1.7 g/cm3 + Epoxy; f=0.147 + Quartz; f=0.773 + Chlorine; f=0.08	<u>Quartz</u> - d=2.2 g/cm3 + Silicon ; n=1 + Oxygen ; n=2

Technological prototype simulation

 $n \rightarrow number of atoms$ $f \rightarrow mass fraction$

+ Hydrogen ; n=3

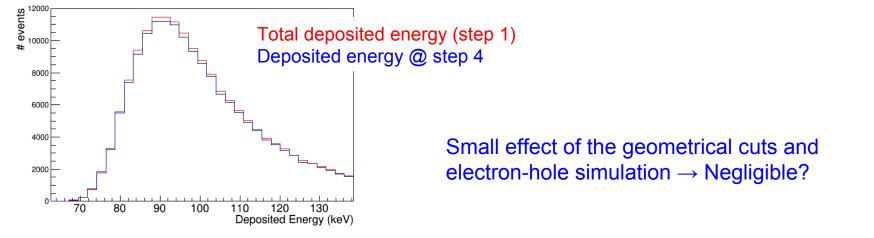
+ Carbon : n=2

+ Chlorine ; n=1

<u>PVC</u> - d=1.4 g/cm3

Energy measurement in simulation - Digitization

- Total energy deposited in one pixel (step 1)
- Geometrical cuts (inter-pixel gap)
- Electron-hole pair production fluctuation
- Electron-hole transport diffusion (step 4)
- Scaling using the landau MPV (keV \rightarrow ADC)
 - + Add PA noise (sigma from 2 to 4 ADC)
 - Apply trigger threshold (1 threshold per channel)
- Add SS noise (sigma = 1.4 ADC)
- Add pedestal (+ 300 ADC)
- Remove channels with switched off PA
 - ASIC data structure in simulation: 1 chip, 1 column, 324 channels



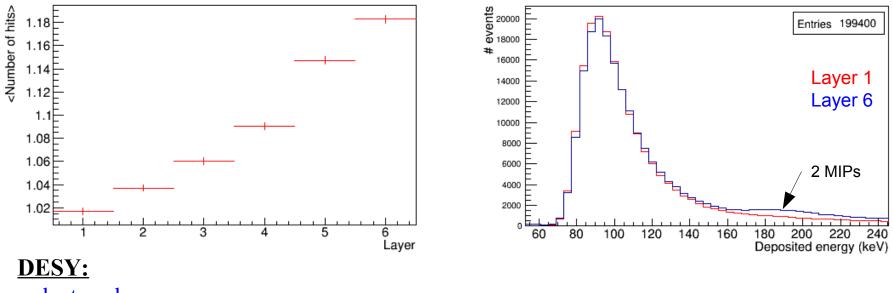
Physics list:
EM option 3 (Standard G4)
e, gamma production cuts = 10 um
Cross section tables: 0,1 keV \rightarrow 100 GeV (2000 bins)
Max step size in wafers = 5 um

Cf = 1,2 pF \rightarrow modify scaling factor and noise for other gains

Not included: dispersion of channel response

Effects of secondary particle production

Without trigger threshold cut



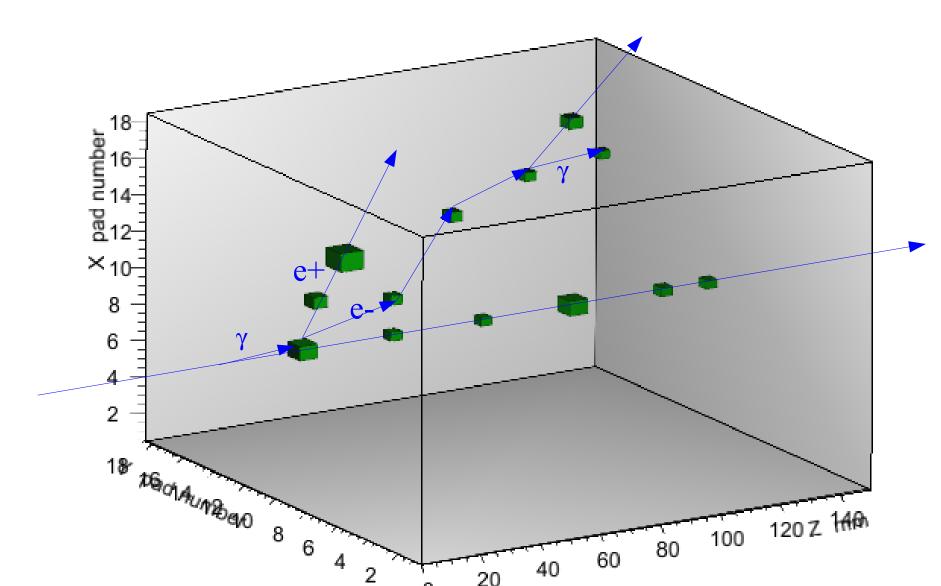
- electron beam
- E from 1 GeV to 5 GeV

Not negligible probability to produce secondary particles \rightarrow Mean number of particles increases as a function of the layer number:

- Mean number of hits per event increases as a function of the layer number (effect on MIP detection efficiency calculation?)

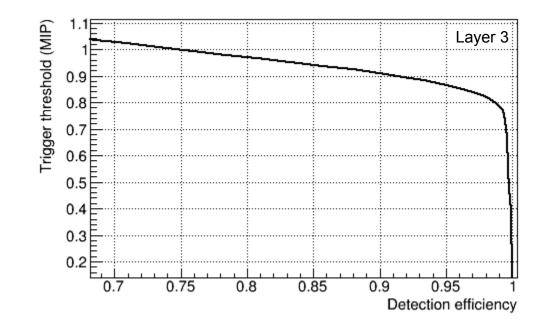
- Energy spectrum is modified as a function of the layer number (effect on MIP energy calibration?)

Secondary particles

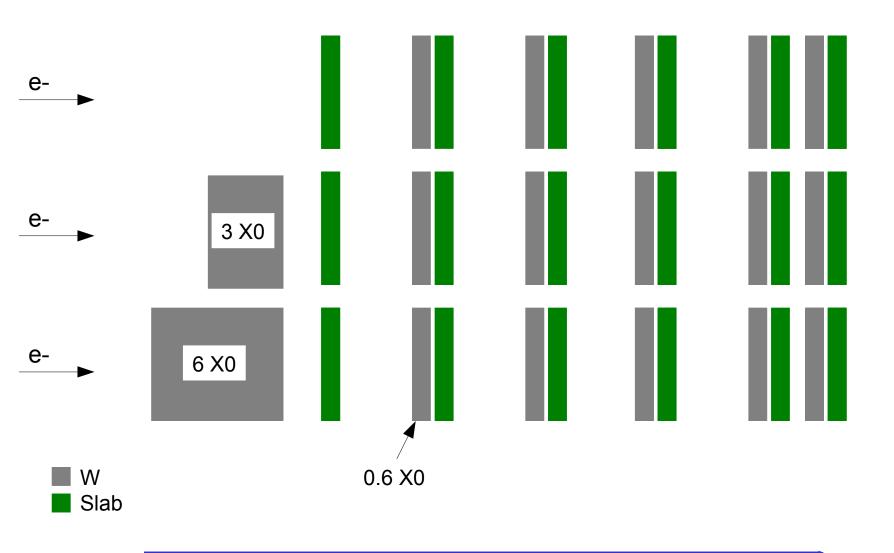


Trigger threshold

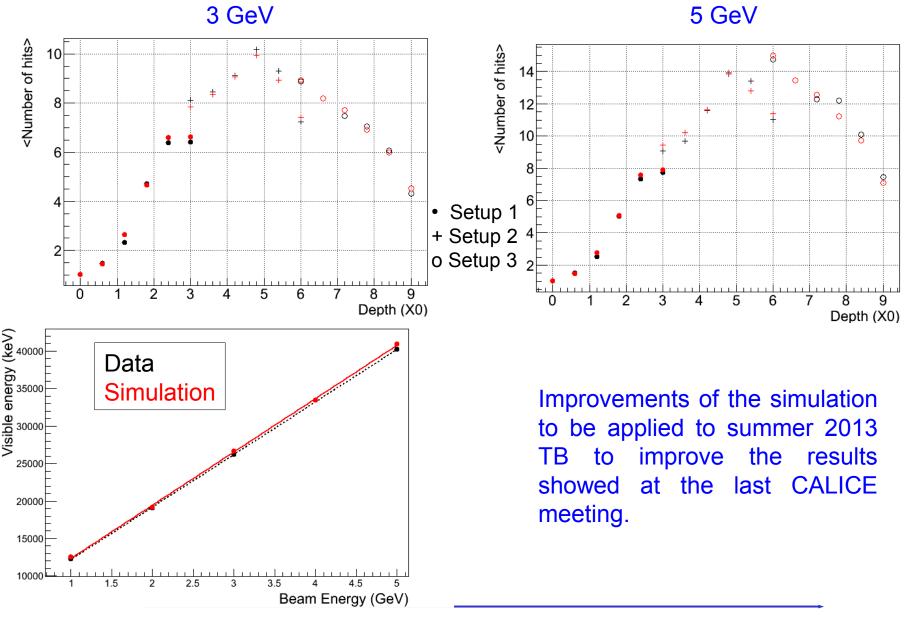
Only the effect of the trigger threshold is studied : with a trigger threshold @0, the detection efficiency is 100% (geometrical effects ==> inefficiency < $2\% \rightarrow$ not taken into account)



Application to showers (summer 2012)



Application to showers (summer 2012)



November 2013